



Illuminating
ENGINEERING SOCIETY

APPROVED METHOD:
MEASURING IN-SITU TEMPERATURE OF
SOLID-STATE LIGHTING COMPONENTS
IN LAMPS AND LUMINAIRES
AN AMERICAN NATIONAL STANDARD



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has been approved by IES.

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should be directed to IES.

**This Approved Method has been prepared
by the IES Testing Procedures Committee.**



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Approved by the IES Standards Committee February 5, 2024, as a Transaction of the Illuminating Engineering Society.

Approved April 23, 2024, as an American National Standard

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Published by the Illuminating Engineering Society, 85 Broad St, New York, NY 10004.

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Printed in the United States of America.

ISBN# 978-0-87995-474-1

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